

FORM HDP-1889 (Base on Form PTO-1449)

## PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

Sheet 1 of 6

ATTORNEY DOCKET NO.	SERIAL NO.
1736-000001/REB	10/643,674
APPLICANT	
Hyon et al.	
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August 19, 2003	1711

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2.	1	4,224,696* /	09/30/1980	Murray et al.		
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4.		4,636,340*	01/13/1987	Itaba et al.	)	
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6.		4,747,990* 🗸	5/31/1988	Gaussens et al.	1	
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15.		5,728,748*	3/17/1998	Sun et al.		
16.		2,948,666 V	8/9/1960	Lawton		
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18.		3,956,253	5/11/1976	Braun		
19.		4,055,862	11/1/1977	Farling		
20.		4,171,338	10/16/1979	Mason	7	
21.	<b>A</b>	4,281,420	8/4/1981	Raab		

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Sheet 2 of 6

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23.		5,200,439	4/6/1993	Asanuma		
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41.	in	6,458,727 B1	10/1/2002	Jones et al.		

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FORM HDP-1449(Bleed on Form PTO-1449)

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Sheet 3 of 6

ATTORNEY DOCKET NO.	SERIAL NO.
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42.	AB	2002/0125614 A1	09/12/02	King et al.		
43.		2002/0037944 A1	03/28/02	Shen et al.		
44.		2003/0119935 A1	06/26/03	Merrill et al.		
45.		6,494,917 B1	12/17/02	McKellop et al.		
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1.	AB	JP 57-211347	12/25/1982	Japan		<u> </u>	Х	
2.		JP 91 22222	5/13/1997	Japan	1		Abstract	
3.		WO 95/06148*	3/2/1995	PCT				
4.		WO 98/01085	1/15/1998	PCT				
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#### FORM HDP-1449 (Bases on Form PTO-1449)

## PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE CITATION

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Sheet 4 of 6

ATTORNEY DOCKET NO.	SERIAL NO.
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7.		EP 0 729 981 A1	9/4/1996	Europe			
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4.		Kitamura, R. et al., "The Properties of Transparent Film Made from Linear Polyethylene By Irradiation Cross-Linking," Macromolecules, vol. 6, 1973, pp. 337-343.*
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Sheet 5 of 6

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10.		Polymer Society, Polymer Functional Material Series-Medical Treatment Functional Material, Vol. 9, November 20, 1990, pp. 165-166.
11.		Polymer Society, Polymer New Material One Point-Medical Polymer Material, Vol. 20, February 20, 1989, pp. 45-46.
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15.		The American Academy of Orthopaedic Surgeons, "Polyethylene: The Past, Present and Future," 1999 Annual Meeting - Scientific Program, February 5, 1999, www.aaos.org/wordhtml/anmett99/sciprog/g.htm (20 pages).
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Sheet 6 of 6

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19.	M	Wilson et al., "Proton Modification of Ultra High Molecular Weight Polyethylene to Promote Crosslinking for Enhanced Chemical and Physical Properties," Materials Research Society Symposium Proceedings, Vol. 396 (1998), pp. 311-316.		

<sup>\*</sup> Indicates previously cited in original U.S. Patent 6,168,626.

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Sheet 1 of 1

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May 8, 2002	<del>3738</del> 17//

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